RF Exposure Evaluation Report

1. Product Information

FCC ID:	2AIY7-CD-1039
Product Name	Wireless charger
Model Number	CD-1039
Dower Supply	Input: DC 5V-3A
Power Supply	Output1: DC 5V-1A, Output2: DC 5V-1A
Modulation Type	Continuous Wave
Frequency Range	115-205KHz
Operation Frequency	160.0 KHz
Antenna Type	Coil Antenna
Hardware version	1.1A
Software version	V1.0
	Mobile Phone (With Wireless Charging Receiver Module)
Accessories	The white phone is RedMi and model is Note4.
	The black phone is a Nut Pro and model is OD105
Exposure category	General population/uncontrolled environment
EUT Type	Production Unit
Device Type	Mobile Device

2. Evaluation Method

Per KDB 680106 D01 Section 3. RF Exposure Requirements;

- 1) Consumer wireless power transfer devices approved under Part 15 and Part 18 in some cases have to demonstrate compliance with RF exposure requirements. The potential for exposure must be assessed according to the operating configurations of the wireless system and the exposure conditions of users and bystanders. RF exposure must be evaluated with the client device(s) being charged by the primary at maximum output power. The RF exposure requirements must be determined in conjunction with the device operating characteristics, according to the mobile and portable exposure requirements in Section 2.1091 and Section 2.1093 of the rules. SAR and MPE limits do not cover the frequency range for wireless power transfer applications which operate below 100 kHz and 300 kHz respectively; therefore, RF exposure compliance needs to be determined with respect to 1.1307 (c) and (d) of the FCC rules.
- 2) Based on the design and implementation of the power transfer application, it must be clearly identified if mobile or portable RF exposure conditions apply. Devices that are installed to provide separation of at least 20 cm from users and bystanders may qualify for mobile exposure conditions. For some conditions where users and bystanders may be exposed at closer than 20 cm, section 2.1091(d) (4) of the rules may apply.
- 3) For devices designed for typical desktop applications, such a wireless charging pads, RF exposure evaluation should be conducted assuming a user separation distance of 15 cm. E and H field strength measurements or numerical modeling may be used to demonstrate compliance. Measurements should be made from all sides and the top of the primary/client pair, with the 15 cm measured from the center of the probe(s) to the edge of the device. Emissions between 100 kHz to 300 kHz should be assessed versus the limits at 300 kHz in Table 1 of Section 1.1310: 614 V/m and 1.63 A/m. A KDB

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inquiry is required to determine the applicable exposure limits below 100 kHz.

- 4) Portable exposure conditions from 100 kHz to 6 GHz are determined with respect to SAR requirements. Existing SAR systems and test procedures are generally intended for measurements above 100 MHz. While numerical modeling can be an alternative, the constraints of substantial computational resources at low frequencies could introduce further limitations. Under these circumstances, including operations below 100 kHz, the Commission may consider a combination of analytical analysis, field strength, radiated and conducted power measurements, in conjunction with some limited numerical modeling to assess compliance.
- 5) Depending on the operating frequency, existing SAR and MPE measurement procedures may be adapted to evaluate wireless power transfer devices for compliance with respect to mobile or portable exposure conditions. If the grantee or its test lab have any questions regarding RF exposure evaluation they should contact the FCC Laboratory with sufficient system operating configuration details to determine if RF exposure evaluation is necessary and, if required, how to apply specific test procedures. Below 100 MHz, when SAR testing is required and the device is operating at close proximity to persons, information on device design, implementation, operating configurations, exposure conditions of users and bystanders are needed to determine the evaluation and testing requirements. In addition, the influence of nearby objects may also need consideration according to the wireless power transfer system implementation; for example, the effects of placing the device, its coils or radiating elements on or near metallic surfaces

3. Evaluation Limit

3.1 Refer evaluation method

ANSI C95.1–1999: IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

FCC KDB publication 680106 D01 RF Exposure Wireless Charging Apps v03: RF Exposure Considerations for Low Power Consumer Wireless Power Transfer Applications

FCC CFR 47 part1 1.1310: Radiofrequency radiation exposure limits.

FCC CFR 47 part2 2.1091: Radiofrequency radiation exposure evaluation: mobile devices

FCC CFR 47 part 18.107: Indusial, Scientific, and Medical Equipment

3.2 Limit

Limits for Maximum Permissible Exposure (MPE)/Controlled Exposure

Frequency	Electric Field	Magnetic Field Power Densit		Averaging Time				
Range(MHz)	Strength(V/m)	Strength(A/m)	(minute)					
Limits for Occupational/Controlled Exposure								
0.3-3.0	614	1.63	*100	6				
3.0-30	1842/f	4.89/f	*900/f ²	6				
30-300	61.4	0.163	1.0	6				
300-1,500	/	/	f/300	6				
1,500-100,000	/	/	5 6					

Limits for Maximum Permissible Exposure (MPE)/Uncontrolle	lled Exposure
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Frequency	Electric Field	Magnetic Field	Power Density	Averaging Time						
Range(MHz)	Strength(V/m)	Strength(A/m) (mW/cm²)		(minute)						
	Limits for General Population/Uncontrolled Exposure									
0.3-1.34	614	1.63	1.63 *100 3							
1.34-30	824/f	2.19/f	*180/f ²	30						
30-300	27.5	0.073	0.2	30						
300-1,500	/	/	f/1500 30							
1,500-100,000	/	/	/ 1.0							

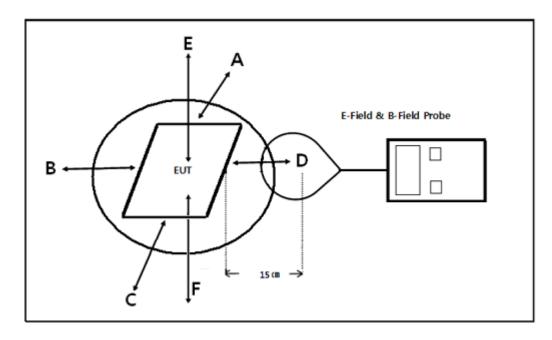
F=frequency in MHz

According to FCC KDB 680106 D01 Section 3. RF Exposure Requirements clause 3 the Emission-Limits in the frequency range from 100 KHz to 300 KHz should be assessed versus the limits at 300 KHz in Table 1 of CFR 47 – Section1.1310 as following (measured distance shall be 15cm from the center of the probe to the edge of the device):

	E-filed	H-filed	B-filed
Frequency	V/m	A/m	uT
0.3 MHz – 3.0 MHz	614	1.613	2.0
3.0 MHz – 30 MHz	824/f (=27.5 _{30MHz})	2.19/f (=0.073 _{30MHz})	

A KDB inquire was required to determine/confirm the applicable limits below 100 KHz.

4. Test Setup Diagram



Due to installation limitations no tests from the underside of the charging device (Test Position F) are required.

^{*=}Plane-wave equivalent power density

5. Test Equipment

Equipment	Manufacturer	Model	Serial no.	Calibrated date	Calibrated Due
Exposure Level Tester	Narda	ELT-400	N-0713	2017-04-03	2018-04-02
B-Field Probe	Narda	ELT-400	M-1154	2017-04-11	2018-04-10

6. Measurement Procedure

- a) The RF exposure test was performed on 360 degree turn table in anechoic chamber.
- b) The measurement probe was placed at test distance (15cm and 20cm) which is between the edge of the charger and the geometric center of probe.
- c) The turn table was rotated 360d degree to search of highest strength.
- d) The highest emission level was recorded and compared with limit as soon as measurement of each points (A, B, C, D, E) were completed.
- e) The EUT were measured according to the dictates of KDB 680106D01v03.

7. Equipment Approval Considerations

The EUT does not fully comply with item 5.2 of KDB 680106 D01 V03 as follows table;

Requirements of KDB 680106 D01	Yes / No	Description			
Power transfer frequency is less than 1 MHz	Yes	The device operate in the frequency range			
Tower transfer frequency is less than I will	103	115.0 KHz - 205.0 KHz			
Output power from each primary coil is less	Yes	The maximum output power of the primary			
than 15 watts	103	coil is 5W each, totally 10W.			
The transfer system includes only single					
primary and secondary coils. This includes		The transfer system includes two same			
charging systems that may have multiple	No	•			
primary coils and clients that are able to	INO	charging circuit part and each part includ one pair of primary and secondary coils.			
detect and allow coupling only between		one pair of primary and secondary cons.			
individual pairs of coils.					
Client device is placed directly in contact with	Yes	Client device is placed directly in contact			
the transmitter.	163	with the transmitter.			
Mobile exposure conditions only (portable					
exposure conditions are not covered by this	Yes	Mobile exposure conditions only			
exclusion).					
The aggregate H-field strengths at 15 cm		The EUT H-field strengths at 15 cm			
surrounding the device and 20 cm above the		surrounding the device and 20 cm above the			
top surface from all simultaneous transmitting	Yes	top surface from all simultaneous			
coils are demonstrated to be less than 50% of		transmitting coils are demonstrated to be			
the MPE limit.		less than 50% of the MPE limit.			

In all other cases, unless excluded above, an RF exposure evaluation report must be reviewed and accepted through a KDB or PBA inquiry to enable authorization of the equipment. When evaluation is required to show compliance; for example, using field strength, power density, SAR measurements or computational modeling etc., the specific authorization requirements will be determined based on the results of the RF exposure evaluation

8. E and H field Strength

8.1 Symbols

For the purpose of the present document, the following symbols apply;

E: Filed strength

H: Magnetic field strength

E_{AVG} = Spatial average of Filed strength

H_{AVG} = Spatial average of Magnetic field strength

E₁: Filed Strength of wireless charge port 1

H₁: Magnetic field strength of wireless charge port 1

E_{1A}: Filed strength of wireless charge port 1 at test position A

H_{1A}: Magnetic field strength of wireless charge port 1 at test position A

8.2 Standalone E-Filed Strength and H-Filed Strength

The three charge ports are same for rated power, tested at charge together and measure each five points; Test mode: Normal Operation (Charging mode)

E-Filed Strength at 15 cm from the edges surrounding the EUT and 15 cm above the top surface

			Me	asured E-Fie	/m)	FCC E-Field	FCC		
Charge Port	Charging Battery Level	Frequency Range (MHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	Strength 50%Limits (V/m)	E-Field Strength Limits(V/ m)
	1%	0.160	5.83	5.49	5.92	5.54	6.76	307.0	614.0
E ₁	50%	0.160	5.47	5.19	5.63	5.18	5.79	307.0	614.0
	99%	0.160	5.05	4.80	5.29	4.81	6.01	307.0	614.0
	1%	0.160	6.02	5.56	6.06	5.57	6.54	307.0	614.0
E ₂	50%	0.160	5.61	5.22	5.66	5.25	5.80	307.0	614.0
	99%	0.160	5.37	4.82	5.37	4.84	5.96	307.0	614.0

H-Filed Strength at 15 cm from the edges surrounding the EUT and 15 cm above the top surface

			Me	easured H-F	ield Strengtl	h Values (A/	m)	FCC	FCC
Charge Port	Charging Battery Level	Frequency Range (MHz)	Test Position A	Test Position B	Test Position C	Test Position D	Test Position E	H-Field Strength 50% Limits (A/m)	H-Field Strength Limits (A/m)
	1%	0.160	0.105	0.091	0.107	0.106	0.128	0.815	1.63
H ₁	50%	0.160	0.097	0.092	0.104	0.097	0.132	0.815	1.63
	99%	0.160	0.076	0.068	0.076	0.074	0.101	0.815	1.63
	1%	0.160	0.114	0.094	0.115	0.112	0.162	0.815	1.63
H ₂	50%	0.160	0.105	0.091	0.107	0.104	0.157	0.815	1.63
	99%	0.160	0.074	0.076	0.079	0.083	0.144	0.815	1.63

H-Field Strength at 20cm from the top surface of the EUT

			Measured H-Field Strength		FCC
Charge	Charging	Frequency Range	Values (A/m)	FCC H-Field Strength	H-Field
Port	Battery Level	(MHz)	Test	50% Limits (A/m)	Strength
1010	Battery Level	(141112)	Position E	30% Lilling (A) III)	Limits
		POSITION E		(A/m)	
	1%	0.160	0.098	0.815	1.63
H ₁	50%	0.160	0.091	0.815	1.63
	99%	0.160	0.065	0.815	1.63
	1%	0.160	0.104	0.815	1.63
H ₂	50%	0.160	0.102	0.815	1.63
	99%	0.160	0.073	0.815	1.63

8.3 Simultaneous E-Filed Strength and H-Filed Strength

KDB 447498 points for simultaneous transmission on far-filed measurement, while for below 30 MHz usually measured at near-filed. KDB680106 require aggregate leakage fields at 15 cm surrounding the device from all simultaneous transmitting coils are demonstrated to be less than 50% of the MPE limit;

KDB680106 can accept using field strength, power density, SAR measurements or computational modeling etc., the specific authorization requirements will be determined based on the results of the RF exposure evaluation.

Test labs suggest use Computational modelling to calculate Nerve Stimulation BRs;

Computational modelling, such as finite-difference time-domain (FDTD) may be used to demonstrate compliance with FCC § 1.1310 limits requirement,

Basic Calculations - The following calculations may be used to evaluate systems without consideration for the effects of phase resulting from multiple frequency and/or multiple antennas co-located in the measurement space, which may overestimate the actual result. If the result exceeds the limits, the advanced calculations described in follows may be used.

$$E_{AVG} = \frac{1}{n} \sum_{i=1}^{n} (E_{MaxRMS})_i$$

Where:

E-field measurements

 E_{AVG} = Spatial average

E_{MaxRMS} = E-field at a measurement point

N = Number of spatially averaged points

And

$$H_{AVG} = \frac{1}{n} \sum_{i=1}^{n} (H_{MaxRMS})_i$$

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Where:

H-field levels of magnetic field strength

H_{AVG} = Spatial average

H_{MaxRMS} = H-field at a measurement point

N = Number of spatially averaged points

E-Filed Strength at 15 cm from the edges surrounding the EUT and 15 cm above the top surface

			Me	asured E-Fie	eld Strengt	h Values (V,	/m)	FCC	FCC
Spatial	Charging	Frequency	Tost	Test	Tost	Test	Test	E-Field	E-Field
•	Battery	Range	Test Position	Position	Test Position	Position	Position	Strength	Strength
Average	Level	(MHz)						50% Limits	Limits
			А	В	С	D	E	(V/m)	(V/m)
	1%	0.160	5.93	5.53	5.99	5.56	6.65	307.0	614.0
E _{AVG}	50%	0.160	5.54	5.21	5.65	5.22	5.80	307.0	614.0
	99%	0.160	5.21	4.81	5.33	4.83	5.99	307.0	614.0

H-Filed Strength at 15 cm from the edges surrounding the EUT and 15 cm above the top surface

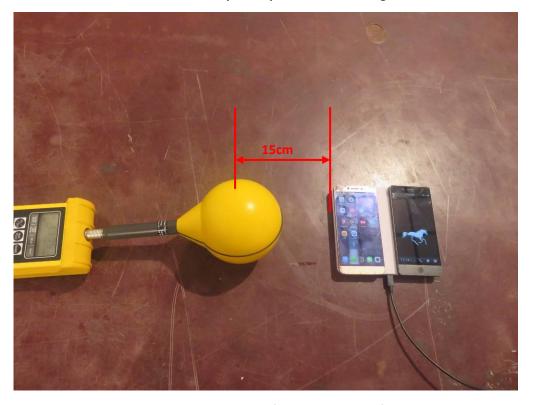
			Me	easured H-F	ield Strengtl	h Values (A/	m)	FCC	FCC
Spatial	Charging	Frequency	Test	Test	Test	Test	Test	H-Field	H-Field
·	Battery	Range	Position	Position	Position	Position	Position	Strength	Strength
Average	Level	(MHz)					Position	50% Limits	Limits
			А	В	С	D	Ц	(A/m)	(A/m)
	1%	0.160	0.110	0.093	0.111	0.109	0.145	0.815	1.63
H_{AVG}	50%	0.160	0.101	0.092	0.106	0.101	0.145	0.815	1.63
	99%	0.160	0.075	0.072	0.078	0.079	0.123	0.815	1.63

H-Field Strength at 20cm from the top surface of the EUT

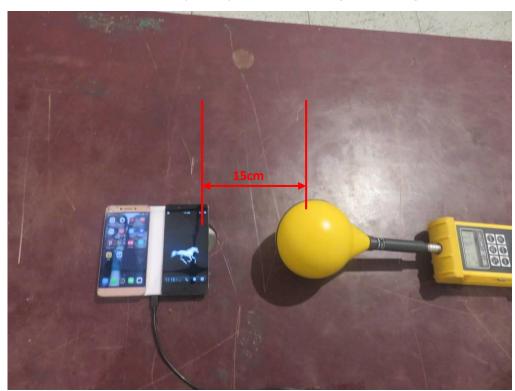
Charge Port	Charging Battery Level	Frequency Range (MHz)	Measured H-Field Strength Values (A/m) Test Position E	FCC H-Field Strength 50% Limits (A/m)	FCC H-Field Strength Limits
H _{AVG}	1%	0.160	0.098	0.815	(A/m) 1.63
	50%	0.160	0.091	0.815	1.63
	99%	0.160	0.065	0.815	1.63

9. Test Setup Photos

TestPosition A-Exposure photo from side edge surface-Left



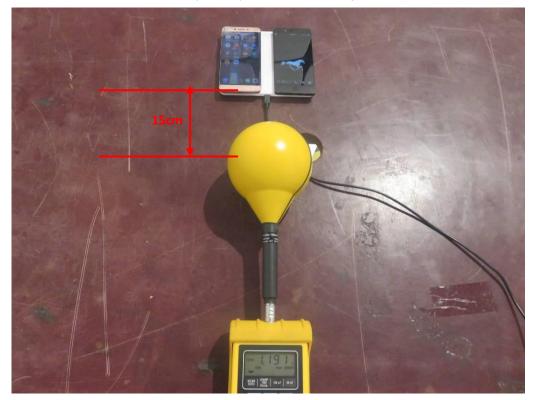
TestPosition B-Exposure photo from side edge surface-Right



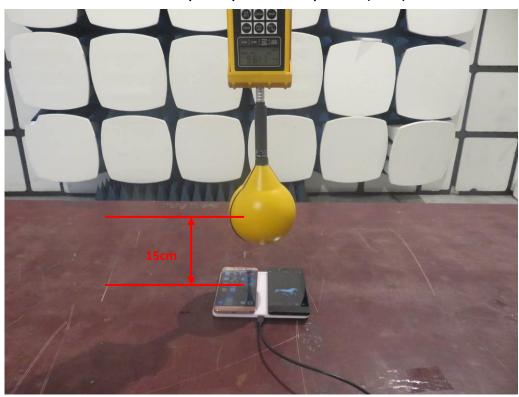
TestPosition C-Exposure photo from side edge surface-Front



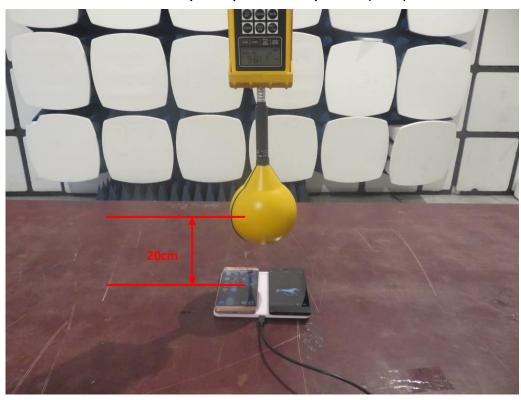
TestPosition D-Exposure photo from side edge surface-Rear



TestPosition E-Exposure photo from top surface(15cm)



TestPosition E-Exposure photo from top surface(20cm)



10. Conclusion

A minimum safety distance of at 15 cm surrounding the device and 20 cm above the top surface of the device is required when the device is charging a smart phone. The detected emissions with a distance of 15 cm surrounding the device and 20 cm above the top surface of the device are below the limitations according to FCC KDB 680106 D01 Section 3. RF Exposure Requirement Clause 3.

Revision History

Revision	Issue Date	Revisions	Revised By
000	April 10, 2018	Initial Issue	Gavin Liang

END	OF	REPORT
END	UΓ	KEPUKI